

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination LEE ET AL.	
		Examiner Kenneth J Whittington	Art Unit 2862	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,339,328 B1	01-2002	Keene et al.	324/248
B	US-5,343,707 A	09-1994	Sata, Ken-ichi	62/6
C	US-5,331,278 A	07-1994	Evanson et al.	324/232
D	US-5,162,731 A	11-1992	Fujimaki, Norio	324/248
E	US-5,254,950 A	10-1993	Fan et al.	324/322
F	US-4,823,081	04-1989	Geisler, Reinhardt	324/225
G	US-5,122,744 A	06-1992	Koch, Roger H.	324/248
H	US-6,462,540 B1	10-2002	Kandori et al.	324/248
I	US-5,187,436 A	02-1993	Mallick, John A.	324/244
J	US-5,894,220 A	04-1999	Wellstood et al.	324/248
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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